

**GJ50L02****N-CHANNEL ENHANCEMENT MODE POWER MOSFET**

BVDSS	25V
RDS(ON)	15mΩ
ID	45A

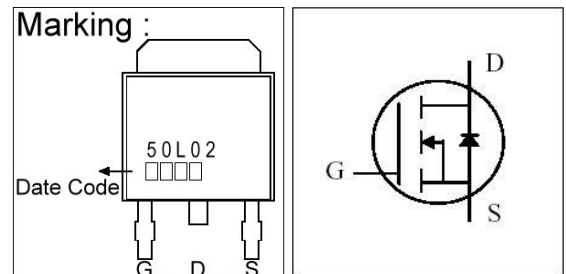
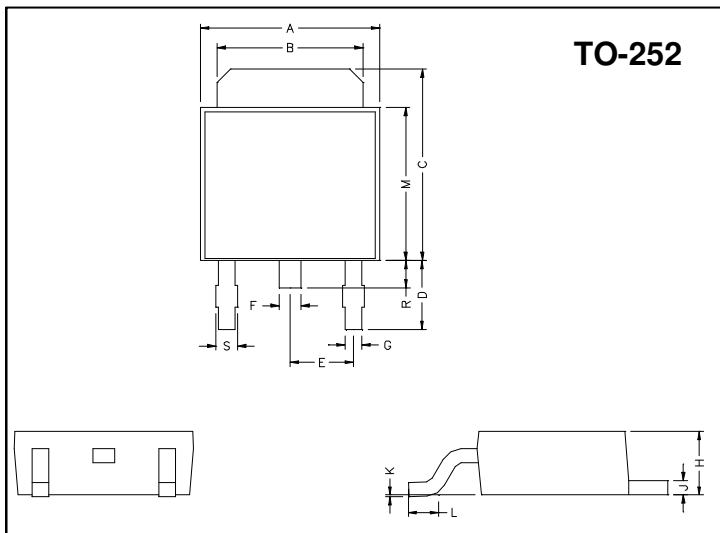
**Description**

The GJ50L02 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-252 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**Features**

- \*Low Gate Charge
- \*Simple Drive Requirement
- \*Fast Switching Characteristic

**Package Dimensions**

REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.40	6.80	G	0.50	0.70
B	5.20	5.50	H	2.20	2.40
C	6.80	7.20	J	0.45	0.55
D	2.40	3.00	K	0	0.15
E	2.30 REF.		L	0.90	1.50
F	0.70	0.90	M	5.40	5.80
S	0.60	0.90	R	0.80	1.20

**Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	$V_{DS}$	25	V
Gate-Source Voltage	$V_{GS}$	±20	V
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=25^{\circ}C$	45	A
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=100^{\circ}C$	30	A
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	140	A
Total Power Dissipation	$P_D @T_C=25^{\circ}C$	44.6	W
Linear Derating Factor		0.36	W/°C
Operating Junction and Storage Temperature Range	$T_j, T_{stg}$	-55 ~ +150	°C

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-case Max.	$R_{thj-c}$	2.8	°C/W
Thermal Resistance Junction-ambient Max.	$R_{thj-a}$	110	°C/W

**Electrical Characteristics (T<sub>j</sub> = 25°C unless otherwise specified)**

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$BV_{DSS}$	25	-	-	V	$V_{GS}=0, I_D=250\mu A$
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_j$	-	0.037	-	V/°C	Reference to 25°C, $I_D=1mA$
Gate Threshold Voltage	$V_{GS(th)}$	1.0	-	3.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Forward Transconductance	$g_{fs}$	-	10	-	S	$V_{DS}=10V, I_D=20A$
Gate-Source Leakage Current	$I_{GSS}$	-	-	±100	nA	$V_{GS}= \pm 20V$
Drain-Source Leakage Current(T <sub>j</sub> =25°C)	$I_{DSS}$	-	-	1	uA	$V_{DS}=25V, V_{GS}=0$
Drain-Source Leakage Current(T <sub>j</sub> =150°C)		-	-	25	uA	$V_{DS}=20V, V_{GS}=0$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	15	mΩ	$V_{GS}=10V, I_D=20A$
		-	-	35		$V_{GS}=4.5V, I_D=10A$
Total Gate Charge <sup>2</sup>	$Q_g$	-	11.5	-	nC	$I_D=20A$ $V_{DS}=20V$ $V_{GS}=5V$
Gate-Source Charge	$Q_{gs}$	-	2.1	-		
Gate-Drain ("Miller") Charge	$Q_{gd}$	-	8.4	-		
Turn-on Delay Time <sup>2</sup>	$T_{d(on)}$	-	7	-	ns	$V_{DS}=15V$ $I_D=20A$ $V_{GS}=10V$ $R_G=3.3\Omega$ $R_D=0.75\Omega$
Rise Time	$T_r$	-	60	-		
Turn-off Delay Time	$T_{d(off)}$	-	17	-		
Fall Time	$T_f$	-	9	-		
Input Capacitance	$C_{iss}$	-	390	-	pF	$V_{GS}=0V$ $V_{DS}=25V$ $f=1.0MHz$
Output Capacitance	$C_{oss}$	-	245	-		
Reverse Transfer Capacitance	$C_{rss}$	-	100	-		

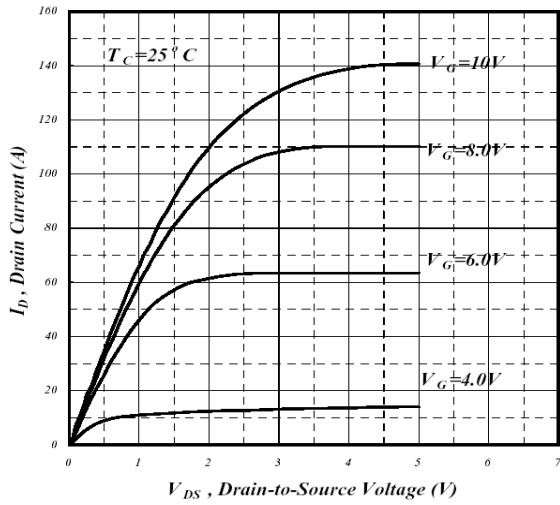
**Source-Drain Diode**

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage <sup>2</sup>	$V_{SD}$	-	-	1.26	V	$I_S=45A, V_{GS}=0V, T_j=25^\circ C$
Continuous Source Current (Body Diode)	$I_S$	-	-	45	A	$V_D=V_G=0V, V_S=1.26V$
Pulse Source Current (Body Diode) <sup>1</sup>	$I_{SM}$	-	-	140	A	

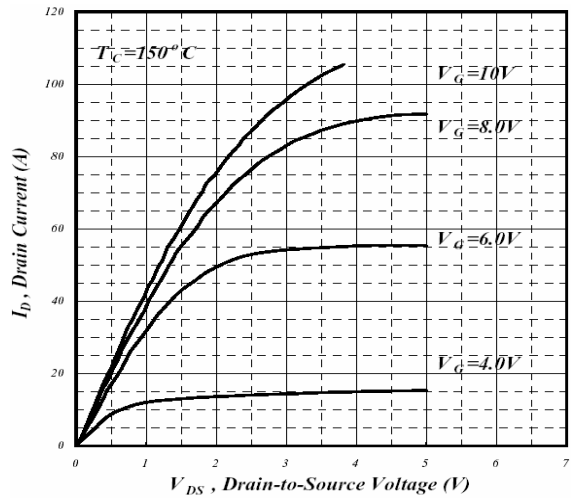
Notes: 1. Pulse width limited by safe operating area.

2. Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .

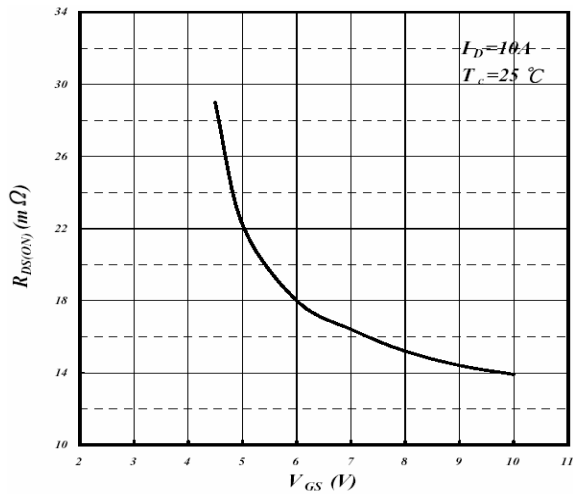
## Characteristics Curve



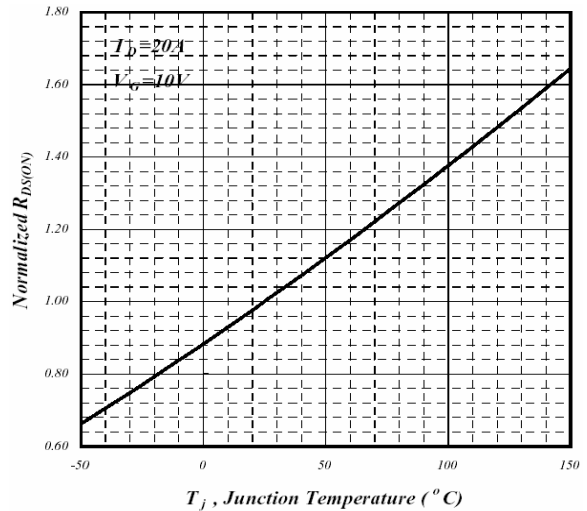
**Fig 1. Typical Output Characteristics**



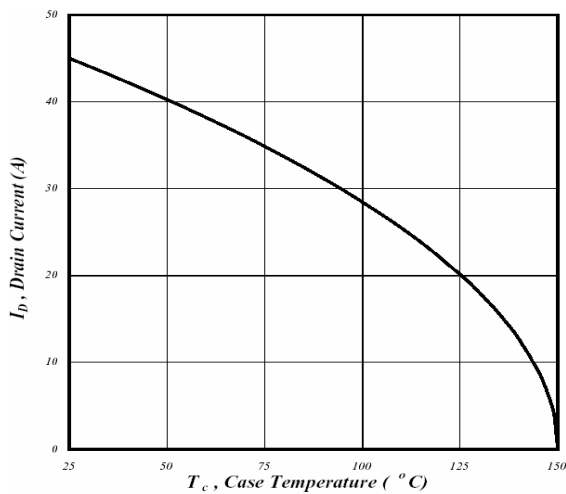
**Fig 2. Typical Output Characteristics**



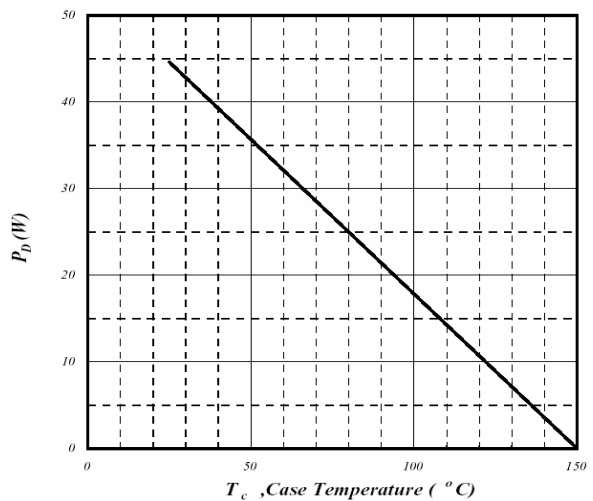
**Fig 3. On-Resistance v.s. Gate Voltage**



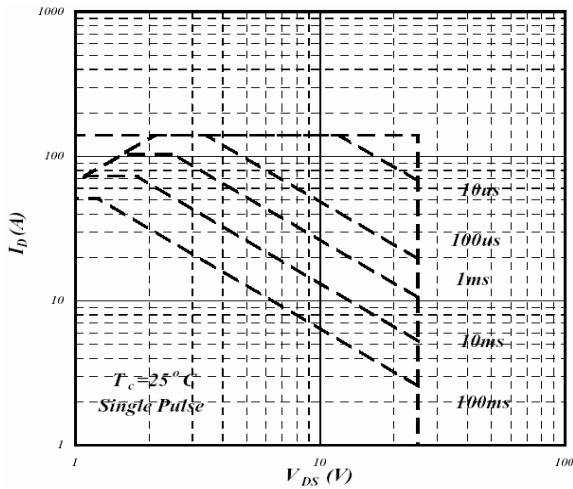
**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



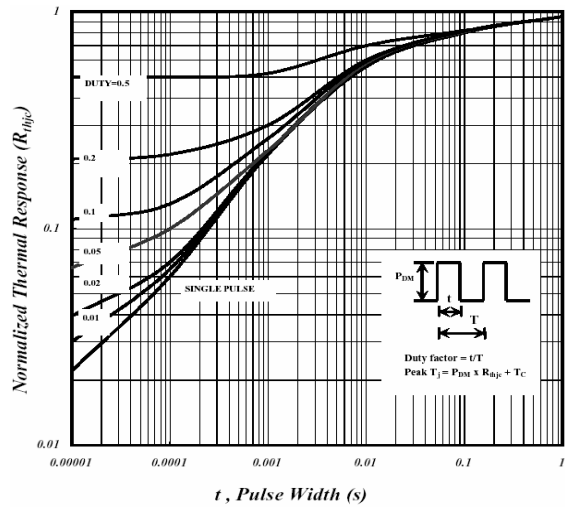
**Fig 5. Maximum Drain Current v.s. Case Temperature**



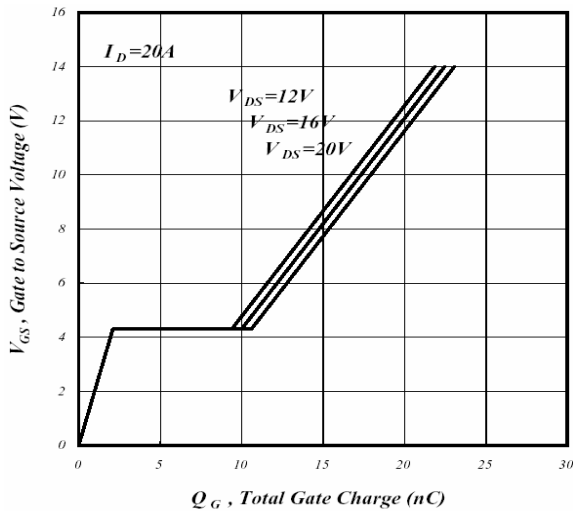
**Fig 6. Type Power Dissipation**



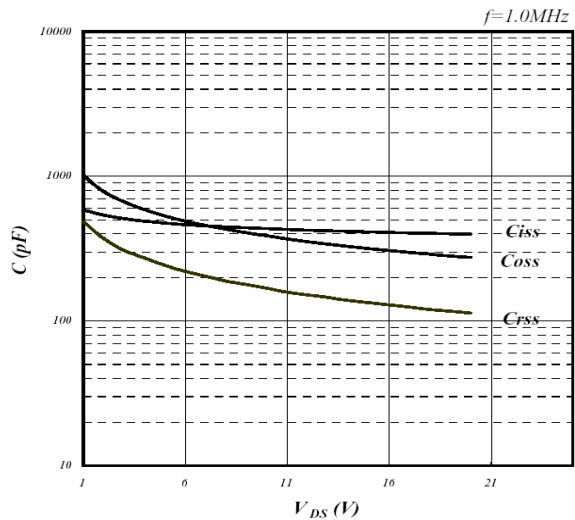
**Fig 7. Maximum Safe Operating Area**



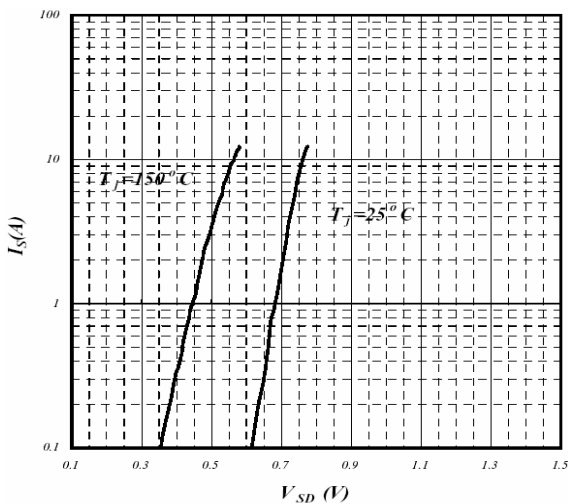
**Fig 8. Effective Transient Thermal Impedance**



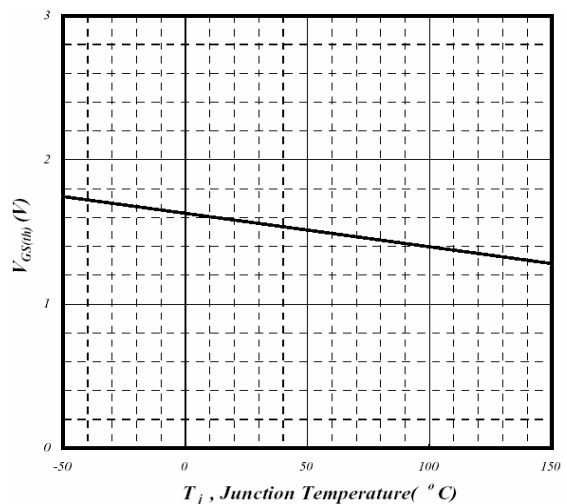
**Fig 9. Gate Charge Characteristics**



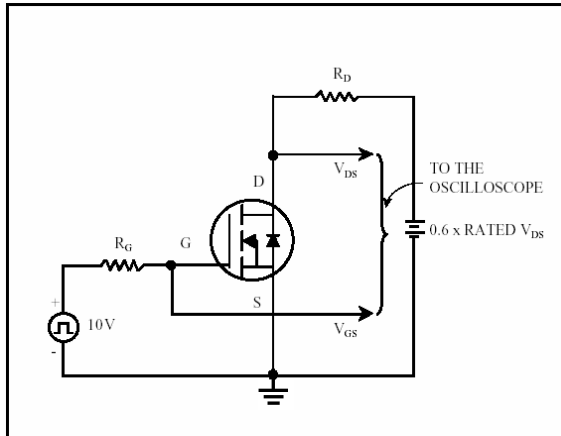
**Fig 10. Typical Capacitance Characteristics**



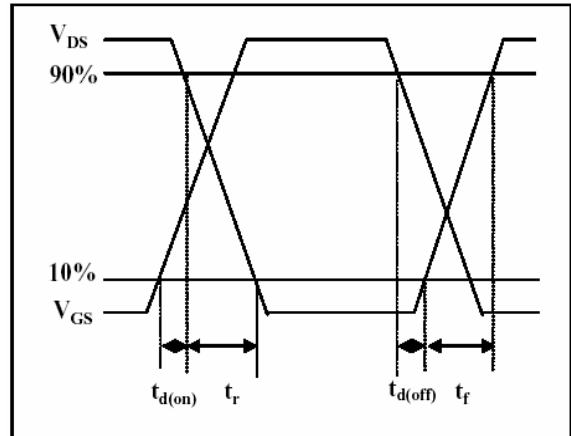
**Fig 11. Forward Characteristics of Reverse Diode**



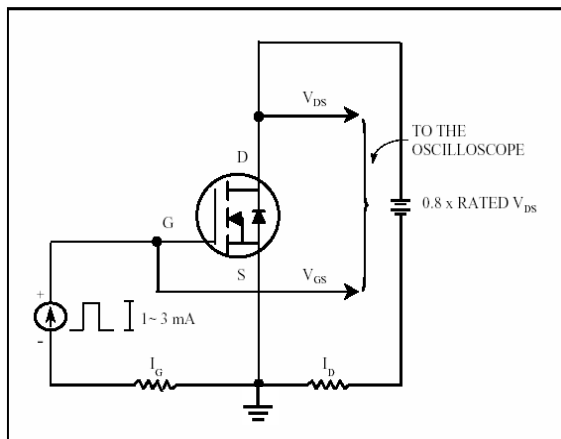
**Fig 12. Gate Threshold Voltage v.s. Junction Temperature**



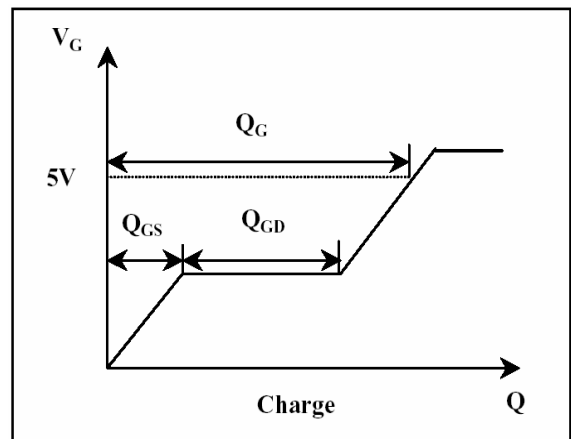
**Fig 13. Switching Time Circuit**



**Fig 14. Switching Time Waveform**



**Fig 15. Gate Charge Circuit**



**Fig 16. Gate Charge Waveform**

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**Head Office And Factory:**

- **Taiwan:** No. 17-1 Tatung Rd. Fu Kou Hsin-Chu Industrial Park, Hsin-Chu, Taiwan, R. O. C.
- TEL : 886-3-597-7061 FAX : 886-3-597-9220, 597-0785
- **China:** (201203) No.255, Jang-Jiang Tsai-Lueng RD. , Pu-Dung-Hsin District, Shang-Hai City, China
- TEL : 86-21-5895-7671 ~ 4 FAX : 86-21-38950165